

<b>Notice of References Cited</b>	Application/Control No. 10/790,932	Applicant(s)/Patent Under Reexamination TANAKA ET AL.	
	Examiner Vaughn T. Coolman	Art Unit 3618	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-1,852,464 A	04-1932	LEIPERT AUGUST H	180/89.16
	B	US-3,147,814 A	09-1964	SUHRE PEARCE E	180/68.1
	C	US-3,709,314 A	01-1973	Hickey, Victor F.	180/249
	D	US-4,350,124 A	09-1982	Kitano et al.	123/198R
	E	US-4,773,675 A	09-1988	Kosuge, Hideyoshi	280/781
	F	US-5,251,713 A	10-1993	Enokimoto, Akio	180/68.4
	G	US-5,950,748 A	09-1999	Matsumoto et al.	180/6.24
	H	US-6,405,823 B1	06-2002	Fukamachi et al.	180/297
	I	US-6,502,659 B2	01-2003	Akasaka, Kousuke	180/309
	J	US-6,622,806 B1	09-2003	Matsuura, Tatsuya	180/68.1
	K	US-6,648,093 B2	11-2003	Rioux et al.	180/291
	L	US-6,695,083 B2	02-2004	Nakamura et al.	180/68.1
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.